

Abstracts

Enhanced Thin-Slot Formalism for the FDTD Analysis of Thin-Slot Penetration

B.-Z. Wang. "Enhanced Thin-Slot Formalism for the FDTD Analysis of Thin-Slot Penetration."
1995 *Microwave and Guided Wave Letters* 5.5 (May 1995 [MGWL]): 142-143.

The inclusion of the singularities of the field variation near a thin-slot is validated to be a useful enhancement of the standard thin-slot formalism for the finite-difference time-domain analysis of thin-slot penetration.

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